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U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO. 34171

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use several sheets if necessary)

APPLICANT: Maurice Lee Smith et al.

FILING DATE: 9/26/2003

GROUP: 2171

U.S. PATENT DOCUMENTS

EXAM. INITIAL DOCUMENT NUM					NUM	ABER DATE			NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE		
/A.H./			6	6	2	6	9	4	1	9/30/03	Knoblach et al.			
			8	8	0	8	5	5	9	8/19/03	Lemelson et al.			
			6	5	8	8	7	٥	1	7/08/03	Yavnai			
			6	4	9	8	0	4	1	12/24/02	Tabacco et al.			
			6	4	9	0	5	3	0	12/03/02	Wyatt			
			6	4	4	6	٥	0	4	9/03/02	Cao et al.			
			6	3	5	6	8	2	5	3/12/02	Castellani et al.			
			6	3	2	7	5	3	5	12/04/01	Evans et al.			
			6	3	1	7	0	8	0	11/13/01	Baxter, Jr.			
			6	1	6	9	4	7	8	01/02/01	Flanagan			
			6	0	8	3	2	4	8	7/04/00	Thompson			
			6	0	7	5	8	9	1	6/13/00	Burman			
			8	0	5	2	1	8	7	4/18/00	Krishnan et al.			
			6	8	2	3	2	2	3	2/08/00	Baxter, Jr.			
			5	9	7	2	6	3	θ	10/26/99	Burlage et al.			
			5	9	3	8	7	2	1	8/17/99	Dussell et al.			
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			5	6	5	8	9	8	0	7/22/97	Benson			
			5	6	4	8	9	1	4	7/15/97	Bauer et al.			
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/Adam Hale/ 10/10/2007 FOREIGN PATENT DOCUMENTS

	 D	OCUM	ENT N	NUMB	R	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
										YES	NO

FORM PTO-1449 (Rev. 2-32)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. SERIAL NO. 10/672,211			
	RMATION DISCLOSURE EMENT BY APPLICANT	APPLICANT: Maurice Lee Smith et al.			
(Use several sheets if necessary)		FILING DATE: 9/26/2003	GROUP: 2878		

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

/A.H./	"Oak Ridge claims sensitivity record for Si MEMS sensor"; June 23, 2003 article in Electronic Engineering Times; Author R. Colin Johnson, page 49.

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

/Adam Hale/ 10/10/2007